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FORM PTO-1441 LIST OF R		CES CITED BY APPLICA	ATTY, DOCKET NO. BOJ-112-A		serial no. Unknown		
				APPUCANT John Bowen			
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EXAMINER INITIALS		PATENT NO.	ISSUE DATE	PATENTEE	CLASS	SUBCLASS	FILING DATE
œ	AA	US2003/0163966	Pub. Date Sept. 4, 2003	Reynolds, et al.	52 .	461	March 1, 2002
<i>\\\</i>	АВ	6,499,262	March 13, 2001	Colson et al.	52	273	Dec. 31, 2002
	AC	2002/0194802	Dec. 26, 2002	Cousin			
	AD	6,199,337	March 13, 2001	Colson et al.	52	506.06	Nov. 20, 1996
	AE	3,844,080	Oct. 29, 1974	Brock et al.	52	222	Jan. 26, 1973
	AF	6,164,364	Dec. 26, 2000	Morris	160	327	June 2, 1999
	AG	5,533,306_	July 9, 1996	Aspenson	52	144	March 29, 1994
	AH	5,413,300	May 9, 1995	Hosteing	248	317	May 13, 1993
	AI	5,224,306	July 6, 1993	Cramer	52	63	Nov. 13, 1991
<u>_</u>	LA	5,209,029	May 11, 1993	Foerst	52	63	Oct. 18, 1991
	AK	5,090,163	Feb. 25, 1992	New	52	39	Feb. 23, 1990
		FORE	IGN PATENT OR PUB	LISHED PATENT APPLICA	TION		
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not considered. Include a copy of this form with next communication to applicant.							

Sheet 2 of 3								
FORM PTO-1440 LIST OF REFERENCES CITED BY APPLICANT				ATTY, DOCKET NO. BOJ-112-A		serial no. Unknown		
				APPUCANT John Bowen				
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EXAMINER INITIALS		PATENT NO.	ISSUE DATE	PATIENTEE	CLASS	SUBCLASS	FILING DATE	
	ВА	5,058,340	Oct. 22, 1991`	Muller	52	222	March 126, 1990	
	ВВ	5,034,042	July 23, 1991	Allen, Jr.	55	385.2	Nov. 27, 1989	
	вс	5,029,422	July 9, 1991	Scherrer	52	222	April 19, 1989	
	BD:	4,986,332	Jan. 22, 1991	Lanuza	160	327	Aug. 9, 1990	
	BE	4,938,819	July 3, 1990	Ishii et al.	156	78	June 7, 1988	
	BF	4,894,960	Jan. 23, 1990	Hill et al.	52	28	March 31, 1988	
	BG	4,887,626	Dec. 19, 1989	Dalo et al.	135	119	Jan. 29, 1988	
	вн	4,835,914	June 6, 1989	Scherrer	52	28	Feb. 22, 1988	
	BI	4,711,060	Dec. 8, 1987	Scherrer	52	222	Sept. 9, 1986	
	ВЈ	4,408,433	Oct. 11, 1983	Scherrer	52	738	Feb. 3, 1981	
	вк	4,210,070	July 1, 1980	Tatum et al.	98	40	March 6, 1978	
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FORM PTO-1449 LIST OF REFERENCES CITED BY APPLICANT				ATTY, DOCKET NO. BOJ-112-A		SERIAL NO. Unknown	
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	CA	4,200,171	April 29, 1980	Seymour et al.	181	287	Dec. 26, 1978
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